Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/512,276	NAGAO ET AL.
Examiner	Art Unit
Louis K. Huvnh	3721

SEARCHED					
Class	Subclass	Date	Examiner		
206	408 446 522 591 594	4/16/2002	LT		
53	472 449	4/16/2002	LT		
Updated	All above	2/4/2003	LT		
53	139.5 49	11/22/2005	LH		
53	449 444 409	11/22/2005	LH		
206	419 421	11/28/2005	LH		
Updated	All above	12/22/2005	LH		
Updated	All above	3/24/2006	LH		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
206, 53	All above	3/24/2006	LH		
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Consulted with John Sipos (class 53) David Fidei (class 206)	4/16/2002	LT
EAST text search "glass base material"	2/11/2003	LT
Interference search in US-PGPUB database - see printout	3/27/2006	LH
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